Attorney Docket: AMKOR-017RCE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE BEFORE THE BOARD OFFICE THE BOARD OFFICE APPEALS AND INTEFERENCES

Applicants: Jong Sik Paek JAN 1 8 2003) Confirmation No. 2822

Serial No.: 10/043,946 (TRADEMINE) Art Unit: 6383

Filed: 01/11/2002) Examiner: Lewis,

For: SEMICONDUCTOR PACKAGE) Monica

APPEAL BRIEF UNDER 37 C.F.R. § 1.192

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

WITH STACKED DIES

Dear Sir/Madam:

Applicant [hereinafter "Appellant"], in the above-captioned patent application, has appealed from the Examiner's final rejection of Claims 1-9, 11 and 19-24 as set forth in the Final Office Action of May 19, 2004.

A Notice of Appeal in response to the Final Office Action was filed on September 17, 2004. The Appeal Brief is being submitted in triplicate pursuant to 37 C.F.R § 1.192(a) with the requisite fee under 37 C.F.R. § 1.17(c) in the amount of \$330. An ORAL HEARING IS NOT REQUESTED.

If for any reason the necessary fee is not associated with this file, the Commissioner is authorized to charge the appropriate fee for the Appeal Brief and/or any necessary extension of time fees to Deposit Account Number 19-4330.

I. • **REAL PARTY IN INTEREST**

The real party in interest is Amkor Technology, Inc. by assignment recorded in the

U.S. Patent and Trademark Office on January 11, 2002 at Reel 012478, Frame 0410.

II. RELATED APPEALS AND INTERFERENCES

No related appeals and/or interferences are pending.

III. STATUS OF CLAIMS

Claims 1-9, 11 and 19-24, the only claims pending in the subject application, stand

finally rejected (see Appendix entitled "CLAIMS ON APPEAL").

IV. STATUS OF AMENDMENTS AFTER FINAL

There are no un-entered amendments.

V. **SUMMARY OF INVENTION**

There has been developed in the prior art various semiconductor packages in which

the internal semiconductor dies of the package or the semiconductor packages themselves are

stacked on each other. For instance, Figure 7 of U.S. Patent No. 6,198,171 to Huang et al.

teaches a semiconductor package 302a having stacked chips 304, 310. However, these

semiconductor packages are often of a size which decreases or diminishes their utility in

certain applications. For example, the semiconductor package 302 is excessively wide due to

the outward spacing of the leads 326 from the stacked chips 304 and 310.

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An aspect of the present invention overcomes this disadvantage by providing a semiconductor package having a more efficient packaging design. Figure 1 provides a crosssectional view of a semiconductor package 100 constructed in accordance with an exemplary embodiment of the present invention. The package 100 comprises a plurality of identically configured leads 130 and a die paddle 135. As seen in Figures 1 and 1A, the innermost end of each lead 130 is disposed in spaced relation to the corresponding peripheral edge segment of the die paddle 135. The package 100 further includes a first semiconductor die 110 including a plurality of bond pads 113 which are disposed on the first surface 111a thereof. The package 100 also includes a second semiconductor die 120 which is stacked upon the first semiconductor die 110 and includes a plurality of bond pads 123 disposed on the second surface 121b thereof.

As seen in Figure 1A, the first semiconductor die 110 and leads 130 are arranged relative to each other such that the bond pads 113 of the die 110 are each oriented between a respective pair of leads 130 when the first surface 111a of the first semiconductor die 110 is bonded to the second surfaces 131b of the leads 130, such that none of the bond pads 113 contact any of the second surfaces 131b of the leads 130. Each of the bond pads 113 of the first semiconductor die 110 is connected the first surface 131a of a respective one of the leads 130 by a first conductive connector 151 such as a conductive wire. Each bond pad 123 of the second semiconductor die 120 is electrically connected to the second surface 131b of a respective one of leads 130 by a second conductive connector 153 such as a conductive wire.

As indicated above, the bond pads 113 of the first semiconductor die 110 are each located between a respective pair of leads 130. Thus, the electrical connection between the bond pads 113 and the first surfaces 131a of the leads 130 through the use of the conductive connectors 151 can be accomplished in a manner wherein the conductive connectors 151 are

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each located inwardly relative to the peripheral edge of the first semiconductor die 110 as

seen in Figures 1 and 1A. Thus, a more efficiently packaged stacked semiconductor package

is provided.

VI. ISSUES.

(A). Whether independent Claim 1 and dependent Claims 2-6 and 9 are improperly

rejected under 35 U.S.C. § 103(a) as being unpatentable over U.S. Patent No. 6,198,171 to

Huang et al. [hereinafter "HUANG"] in view of U.S. Patent No. 6,198,171 to Abe

[hereinaster "ABE"]; and whether dependent Claims 7 and 8 are improperly rejected under

35 U.S.C. § 103(a) as being unpatentable over HUANG in view of ABE and Korean

Publication No. 2002-0049944 to Song [hereinafter "SONG"].

(B). Whether dependent Claim 11 is improperly rejected under 35 U.S.C. § 103(a)

as being unpatentable over HUANG in view of ABE; and

(C). Whether independent Claim 19 and dependent Claims 20-24 are improperly

rejected under 35 U.S.C. § 103(a) as being unpatentable over HUANG in view of ABE.

VII. GROUPING OF CLAIMS

For the purpose of this Appeal, Appellant submits that:

(A). Independent Claim 1 and dependent Claims 2-9 stand or fall together;

(B). Dependent Claim 11 (from Claim 1) stands alone; and

(C). Independent Claim 19 and dependent Claims 20-24 stand or fall together.

The reasons why the three groups of claims are believed to be separately patentable

are explained below in the following Arguments Section.

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VIII. ARGUMENTS

(A). The rejection of independent Claim 1 and dependent Claims 2-6 and 9 under 35

U.S.C. § 103(a) as being unpatentable over HUANG in view of ABE is in error, the

rejection should be reversed, and the application should be remanded to the Examiner

with instructions to allow Claims 1-6 and 9. Additionally, the rejection of dependent

Claims 7 and 8 under 35 U.S.C. § 103(a) as being unpatentable over HUANG in view of

ABE and Korean Publication No. 2002-0049944 to Song [hereinafter "SONG"] is in

error, the rejection should be reversed, and the application should be remanded to the

Examiner with instructions to allow Claims 7-8.

The Examiner's Rejection

In regard to independent Claim 1, the Examiner admits that HUANG fails to disclose

"portions of the first surface directly attached to the second surface of each of the leads".

The Examiner then submits that it would have been obvious to one of ordinary skill in the art

at the time the invention was made to modify the semiconductor device of HUANG to

include portions of the die attached to the leads as disclosed in ABE because it aids in

reducing manufacturing costs. Further, the Examiner submits that HUANG and ABE are

both from the same field of endeavor, and that the purpose disclosed by ABE would have

been recognized in the pertinent art of HUANG.

A Review of HUANG

In the embodiment of the semiconductor package shown in Figure 7 of HUANG, a first or lower chip 304 is shown as being mounted to the top surface of the die pad 318 via a layer of adhesive 322. Disposed about the periphery of the die pad 318 are a plurality of leads 326, each of which includes a first or top surface 328a, and a second or bottom surface 328b which has a stepped structure defining a protruded zone 330. Stacked upon the lower first chip 304 is an upper second chip 310 which is secured to the first chip 304 by a layer of adhesive 324. As clearly shown in Figure 7, no portion of the lower surface of the chip 304 is attached to the first or top surfaces 328a of the leads 326. Rather, the leads 326 are disposed well outward of the peripheral edges of the first and second chips 304, 310.

A Review of ABE

ABE discloses a semiconductor device 1 having a leadframe 10 and a semiconductor element 14 which is mounted to the leadframe 10 through the use of an adhesive tape 12. The semiconductor element 14 is electrically connected to the leadframe 10 through the use of bonding wires 16 which, along with the semiconductor element 14, are sealed or encapsulated with a resin material 18. The leadframe 10 of the semiconductor device 1 in the ABE reference includes a plurality of terminal portions 10a which protrude through the substrate mount surface of the resin material 18 and each have a solder layer 19 applied thereto. The application of the solder layer 19 to each of the terminal portions 10a is made possible by the protrusion of the terminal portions 10a through the substrate mount surface of the resin material 18 which allows the terminal portions 10a to be used as connecting terminals, thereby eliminating the need for solder balls for mounting as required in

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tional ball-grid array semiconductor devices, and thus, providing substantially

I material and manufacturing costs (see ABE specification, column 3, lines 46-58).

dependent Claim 1

Independent Claim 1 as amended recites, inter alia, "... portions of the first surface

first semiconductor die being directly attached to the second surface of each of the

uch that each of the bond pads of the first semiconductor die is located between a

ive pair of the leads so that the bond pads of the first semiconductor die do not

the second surface of any one of the leads; ...".

Appellant respectfully submits that the combined teachings of HUANG and ABE

do not teach or suggest any embodiment of a semiconductor package having the

entioned features recited in independent Claim 1.

y, it is noted that the motivation to modify HAUNG with the teachings of ABE as

ed by the Examiner is defective.

The Examiner contends that it would have been obvious to one of ordinary skill in the

nodify the semiconductor device of HUANG to include portions of the die attached to

ds as disclosed in ABE because it aids in reducing manufacturing cost. Appellant

es.

It is well established that it must be shown that there was a suggestion, i.e., a

tion to combine something to suggest the desirability, and thus the obviousness, of

the combination. Lindermann Maschinenhfabrik GMBH v. American Hoist and

k. Co., 730 F.2d 1452, 1462, 221 USPQ 481, 488 (Fed Cir. 1984). Obviousness cannot

iblished by combining references without also providing evidence of the motivating

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force which would impel one skilled in the art to do what the Appellant has done. Ex parte Levengood, 28 USPQ2d 1300, 1302 (Bd Pat. App. & Inter. 1993).

To find motivation, the Examiner makes reference to the passage of the specification

of ABE beginning in column 1, line 50 and ending in column 2, line 19. However, this

language simply mirrors that described above in column 3, lines 46-58 of the ABE reference.

In this regard, both the language of this passage and that cited by the Examiner demonstrates

that the reduction in manufacturing costs discussed in ABE has absolutely nothing to do with

the attachment of the semiconductor element 14 to the leadframe 10 through the use of the

adhesive tape 12. Rather, the manufacturing cost reductions discussed in ABE are achieved

by the protrusion of the terminal portions 10a through the substrate mount surface of the

resin material 18 and application of the solder layers 19 thereto which allows the terminal

portions 10a to be used as connecting terminals. There is simply no teaching or suggestion in

the ABE reference regarding a correlation between the reduction in manufacturing costs as

argued by the Examiner and the attachment of the semiconductor element 14 to the leadframe

10. Thus, it appears the motivation given by the Examiner to combine the ABE leads to the

HUANG package to reduce manufacturing costs is defective.

Accordingly, it is submitted that the Examiner has failed to provide sufficient

motivation for the proposed modification, and thus the rejection of at least independent

Claim 1 under 35 U.S.C. § 103(a) is improper for the aforementioned reasons and should be

withdrawn.

Additionally, the Appellant's disclosure may not be used as a template for a rejection (i.e.

the Examiner has used impermissible hindsight to find motivation).

Appellant also notes that the Examiner has the initial duty of supplying the factual

basis for the rejection and may not, because of doubt that the invention is patentable, resort to

speculation, unfounded assumption or hindsight reconstruction to supply deficiencies in the

factual basis. See In re Warner, 379 F.2d 1011, 1017, 154 USPQ 173, 177 (CCPA 1967).

As stated in W.L. Gore & Associates, Inc. v. Garlock, Inc., 721 F.2d 1540, 1533, 220 USPQ

303, 312-313 (Fed. Cir. 1983), cert denied, 469 U.S. 851 (1984):

[t]o imbue one of ordinary skill in the art with knowledge of the invention in suit, when no prior art reference or references of record convey or suggest that

knowledge, is to fall victim to the insidious effect of a hindsight syndrome

wherein that which the inventor taught is used against it teacher.

Appellant submits that it is highly likely that the modification of HUANG in view of

ABE as proposed by the Examiner has resulted from a review of Appellant's disclosure and

the application of impermissible hindsight to find motivation.

In particular, Appellant submits that the Examiner has merely used the Appellant's

disclosure as a template to find obvious the features of independent Claim 1 which recites,

inter alia, ". . . portions of the first surface of the first semiconductor die being directly

attached to the second surface of each of the leads such that each of the bond pads of the first

semiconductor die is located between a respective pair of the leads so that the bond pads of

the first semiconductor die do not contact the second surface of any one of the leads; ... ".

Accordingly, it is submitted that the Examiner has used impermissible hindsight to

find motivation for the proposed modification, and thus the rejection of at least independent

Claim 1 under 35 U.S.C. § 103(a) is improper and should be withdrawn for this additional

reason.

Moreover, the combination which the Examiner presents does not result in the invention

that the Appellant claims, therefore, the aforementioned rejection is inappropriate.

With respect to the aforementioned rejection, the Examiner has not provided a prior

art reference or references which teach or suggest all the claim limitations of the pending

claims.

To establish a prima facie case of obviousness, the prior art reference (or references

when combined) must teach or suggest all the claim limitations. See Litton Industrial

Products, Inc. v. Solid State Systems, Corp., 755 F.2d 158, 164, 225 U.S.P.Q. 34, 38 (Fed.

Cir. 1985) ("The references fail not only to expressly disclose the claimed invention as a

whole, but also to suggest to one of ordinary skill in the art modifications needed to meet all

the claim limitations").

Even assuming, arguendo, that the hypothetical combination of the HUANG and

ABE references is proper (which the Appellant disputes), Appellant respectfully submits that

such combination still does not teach or suggest the relative orientations between the bond

pads of the first semiconductor die and the leads as recited in independent Claim 1.

As already discussed, a review of Figure 4 of HUANG and the corresponding passage

of the specification thereof demonstrates that if the leads 326 were enlarged to extend

beneath the first chip 304 or positioned further inboard underneath first chip 304, many if not

all of the bonding pads 308 of the first chip 304 would be completely or at least partially

covered by the leads 326, as opposed to the bonding pads 308 being oriented between

respective pairs of the leads 326.

On the other hand, the present invention clearly teaches and claims a spatial

relationship between the bond pads 113 and leads 130. In this regard, there is clearly no

teaching in HUANG regarding the orientation of the first bonding pads 308 of the first chip 304 between respective pairs of the leads 326.

In particular, neither HUANG nor ABE, when considered individually or in combination teach or suggest, inter alia, ". . . portions of the first surface of the first semiconductor die being directly attached to the second surface of each of the leads such that each of the bond pads of the first semiconductor die is located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact the second surface of any one of the leads; ... "as is recited in independent Claim 1.

Accordingly, it is submitted that the proposed combination of HUANG and ABE does not result in the invention recited in at least independent Claim 1, and therefore, the rejection of Claim 1 under 35 U.S.C. § 103(a) is improper for the aforementioned reasons and should be withdrawn.

And finally, the manner in which the Examiner modifies HUANG in view of ABE renders the HUANG reference unsatisfactory for its intended purpose.

Appellant submits that the manner in which the Examiner has modified HUANG in view of ABE renders the HUANG reference unsatisfactory for its intended purpose. It is well settled that a proposed modification cannot destroy a reference by rendering the prior art invention being modified unsatisfactory for its intended purpose. In re Gordon, 733 F.2d 900, 90, 221 USPQ 1125, 1127 (Fed. Cir. 1984).

As discussed above, the Examiner submits that it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the semiconductor device of HUANG to include portions of the die attached to the leads as disclosed in ABE.

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A review of Figure 4 of HUANG and the corresponding passage of the specification

thereof demonstrates that if the leads 326 were enlarged to extend beneath the first chip 304

or repositioned further inboard beneath first chip 304, many if not all of the bonding pads

308 of the first chip 304 would be completely or at least partially covered by the leads 326,

as opposed to the bonding pads 308 being oriented between respective pairs of the leads 326.

Therefore, the manner in which the Examiner has modified HUANG in view of ABE renders

the HUANG reference unsatisfactory for its intended purpose. Furthermore, neither

HUANG or ABE, when considered individually or in combination teach or even remotely

suggest the spatial relationship between the bond pads 113 (i.e., the bonding pads 308 being

oriented between respective pairs of the leads 326) and leads 130 of the present invention as

recited in independent Claim 1.

Accordingly, it is submitted that the Examiner has inappropriately modified HUANG

in view of ABE, and as result destroyed the function of the HUANG reference. Thus,

Appellant respectfully submits that the rejection of at least independent Claim 1 under 35

U.S.C. § 103(a) is improper and should be withdrawn.

In re Dependent Claims 2-9

Furthermore, Appellant submits that dependent Claims 2-9 are allowable at least for

the reason that these claims depend from allowable independent Claim 1 and because these

claims recite additional features that further define the present invention.

Accordingly, Appellant respectfully submits that the rejection of dependent Claims 2-

9 under 35 U.S.C. § 103(a) is improper and should be withdrawn.

The rejection of dependent Claim 11 under 35 U.S.C. § 103(a) as being **(B)**.

unpatentable over HUANG in view of ABE is in error, the rejection should be reversed,

and the application should be remanded to the Examiner with instructions to allow

dependent Claim 11.

The Examiner's Rejection

In regard to dependent Claim 11, the Examiner submits that HUANG discloses that

(a) the first semiconductor die defines a peripheral edge (citing Figure 7); and that (b) the

conductive connectors electrically connecting the bond pads of the first semiconductor die to

the leads are oriented inwardly relative to the peripheral edge of the first semiconductor die

(citing Figure 7).

'In re Dependent Claim 11

Dependent Claim 11 recites, inter alia, ". . . the conductive connectors electrically

connecting the bond pads of the first semiconductor die to the leads are oriented inwardly

relative to the peripheral edge of the first semiconductor die.

Appellant respectfully submits that the combined teachings of HUANG and ABE

clearly do not teach or suggest any embodiment of a semiconductor package having the

aforementioned features recited in dependent Claim 11.

It is noted that neither HUANG nor ABE teach the conductive connectors (such as

wires) electrically connecting the bond pads of a first semiconductor die to the leads being

oriented inwardly relative to the peripheral edge of the first semiconductor die.

For instance, a review of HUANG (all Figures) reveals that wires 216 are oriented

outwardly relative to the peripheral edge of the semiconductor die 208 - not inwardly as the

Appellant recites in dependent Claim 11. Furthermore, nowhere in the HUANG reference is

there any suggestion that the wires 216 can be or that it is desirable that the HUANG wires

be oriented inwardly relative the peripheral edge of the semiconductor die 208.

Also, a review of ABE (all Figures) reveals that wires 16 are oriented outwardly

relative to the peripheral edge of the semiconductor die 14 - not inwardly as the Appellant

recites in dependent Claim 11. Furthermore, nowhere in the ABE reference is there any

suggestion that the ABE wires 16 can be or that it is desirable that the ABE wires 16 be

oriented inwardly relative the peripheral edge of semiconductor die 14. If anything, ABE

teaches away from the aforementioned feature recited in dependent Claim 11. For instance,

it is noted that ABE does not even teach a die pad to which the ABE die 14 may be attached.

Instead, ABE utilizes adhesive tape 12 to attach the die 14 to the top portion of the lead

frame 10. Therefore, it is apparent that the ABE adhesive tape 12 would not allow the ABE

wires to be routed inward.

Accordingly, Appellant respectfully submits that the rejection of dependent Claim 11

under 35 U.S.C. § 103(a) is improper and should be withdrawn.

The rejection of independent Claim 19 and dependent Claims 20-24 under 35 (C).

U.S.C. § 103(a) as being unpatentable over HUANG in view of ABE is in error, the

rejection should be reversed, and the application should be remanded to the Examiner

with instructions to allow Claims 19-24.

The Examiner's Rejection

In regard to independent Claim 19, the Examiner admits that HUANG fails to

disclose "portions of the first surface directly attached to the second surface of each of the

leads". The Examiner then submits that it would have been obvious to one of ordinary skill

in the art at the time the invention was made to modify the semiconductor device of HUANG

to include portions of the die attached to the leads as disclosed in ABE because it aids in

reducing manufacturing costs. Further, the Examiner submits that HUANG and ABE are

both from the same field of endeavor, and that the purpose disclosed by ABE would have

been recognized in the pertinent art of HUANG.

In re Claims Independent Claim 19

Independent Claim 19 as amended recites, inter alia, ". . . the first semiconductor die

being directly attached to each of the leads such that each of the bond pads of the first

semiconductor die is located between a respective pair of the leads so that the bond pads of

the first semiconductor die do not contact any of the leads; ... ".

Appellant respectfully submits that the combined teachings of HUANG and ABE

clearly do not teach or suggest any embodiment of a semiconductor package having the

aforementioned features recited in independent Claim 19.

Once again, it is noted that the motivation to modify HUANG with the teachings of ABE as

proposed by the Examiner is defective.

The Examiner contends that it would have been obvious to one of ordinary skill in the

art to modify the semiconductor device of HUANG to include portions of the die attached to

the leads as disclosed in ABE because it aids in reducing manufacturing cost. Appellant

disagrees.

To find motivation, the Examiner makes reference to the passage of the specification

of ABE beginning in column 1, line 50 and ending in column 2, line 19. However, this

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language simply mirrors that described above in column 3, lines 46-58 of the ABE reference.

In this regard, both the language of this passage and that cited by the Examiner demonstrates

that the reduction in manufacturing costs discussed in ABE has absolutely nothing to do with

the attachment of the semiconductor element 14 to the leadframe 10 through the use of the

adhesive tape 12. Rather, the manufacturing cost reductions discussed in ABE are achieved

by the protrusion of the terminal portions 10a through the substrate mount surface of the

resin material 18 and application of the solder layers 19 thereto which allows the terminal

portions 10a to be used as connecting terminals. There is simply no teaching or suggestion in

the ABE reference regarding a correlation between the reduction in manufacturing costs as

argued by the Examiner and the attachment of the semiconductor element 14 to the leadframe

10. Thus, it appears the motivation given by the Examiner to combine the ABE leads to the

HUANG package to reduce manufacturing costs is defective.

Accordingly, it is submitted that the Examiner has failed to provide sufficient

motivation for the proposed modification, and thus the rejection of at least independent

Claim 19 under 35 U.S.C. § 103(a) is improper for the aforementioned reasons and should be

withdrawn.

Additionally, the Appellant's disclosure may not be used as a template for a rejection (i.e.

the Examiner has used impermissible hindsight to find motivation).

Appellant submits that it is highly likely that the modification of HUANG in view of

ABE as proposed by the Examiner has resulted from a review of Appellant's disclosure and

the application of impermissible hindsight to find motivation.

In particular, Appellant submits that the Examiner has merely used the Appellant's

disclosure as a template to find obvious the features of independent Claim 19 as amended

which recites, inter alia, ". . . the first semiconductor die being directly attached to each of

the leads such that each of the bond pads of the first semiconductor die is located between a

respective pair of the leads so that the bond pads of the first semiconductor die do not

contact any of the leads; ... ".

Accordingly, it is submitted that the Examiner has used impermissible hindsight to

find motivation for the proposed modification, and thus the rejection of at least independent

Claim 19 under 35 U.S.C. § 103(a) is improper and should be withdrawn for this additional

reason.

Moreover, the combination which the Examiner presents does not result in the invention

that the Appellant claims, therefore, the aforementioned rejection is inappropriate.

With respect to the aforementioned rejection, the Examiner has not provided a prior

-art reference or references which teach or suggest all the claim limitations of the pending

claims.

Even assuming, arguendo, that the hypothetical combination of the HUANG and

ABE references is proper (which the Appellant disputes), Appellant respectfully submits that

such combination still does not teach or suggest the relative orientations between the bond

pads of the first semiconductor die and the leads as recited in independent Claim 19.

As already discussed, a review of Figure 4 of HUANG and the corresponding passage

of the specification thereof demonstrates that if the leads 326 were enlarged to extend

beneath the first chip 304 or positioned further inboard underneath first chip 304, many if not

all of the bonding pads 308 of the first chip 304 would be completely or at least partially

covered by the leads 326, as opposed to the bonding pads 308 being oriented between

respective pairs of the leads 326.

On the other hand, the present invention clearly teaches and claims a spatial relationship between the bond pads 113 and leads 130. In this regard, there is clearly no teaching in HUANG regarding the orientation of the first bonding pads 308 of the first chip 304 between respective pairs of the leads 326.

In particular, neither HUANG nor ABE, when considered individually or in combination teach or suggest, inter alia, ". . . the first semiconductor die being directly attached to each of the leads such that each of the bond pads of the first semiconductor die is located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact any of the leads; . . . " as is recited in independent Claim 19.

Accordingly, it is submitted that the proposed combination of HUANG and ABE does not result in the invention recited in at least independent Claim 19, and therefore, the -rejection of Claim 19 under 35 U.S.C. § 103(a) is improper for the aforementioned reasons and should be withdrawn.

And finally, the manner in which the Examiner modifies HUANG in view of ABE renders the HUANG reference unsatisfactory for its intended purpose.

Appellant submits that the manner in which the Examiner has modified HUANG in view of ABE renders the HUANG reference unsatisfactory for its intended purpose.

As discussed above, the Examiner submits that it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the semiconductor device of HUANG to include portions of the die attached to the leads as disclosed in ABE.

A review of Figure 4 of HUANG and the corresponding passage of the specification thereof demonstrates that if the leads 326 were enlarged to extend beneath the first chip 304

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or repositioned further inboard beneath first chip 304, many if not all of the bonding pads

308 of the first chip 304 would be completely or at least partially covered by the leads 326.

as opposed to the bonding pads 308 being oriented between respective pairs of the leads 326.

Therefore, the manner in which the Examiner has modified HUANG in view of ABE renders

the HUANG reference unsatisfactory for its intended purpose. Furthermore, neither

HUANG or ABE, when considered individually or in combination teach or even remotely

suggest the spatial relationship between the bond pads 113 (i.e., the bonding pads 308 being

oriented between respective pairs of the leads 326) and leads 130 of the present invention as

recited in independent Claim 19.

Accordingly, it is submitted that the Examiner has inappropriately modified HUANG

in view of ABE, and as result destroyed the function of the HUANG reference. Thus,

Appellant respectfully submits that the rejection of at least independent Claim 19 under 35

·U.S.C. § 103(a) is improper and should be withdrawn.

In re Dependent Claims 20-24

Furthermore, Appellant submits that dependent Claims 20-24 are allowable at least

for the reason that these claims depend from allowable independent Claim 19 and because

these claims recite additional features that further define the present invention.

Accordingly, Appellant respectfully submits that the rejection of dependent Claims

20-24 under 35 U.S.C. § 103(a) is improper and should be withdrawn.

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Application is Allowable

Appellant respectfully submits that each and every pending claim of the present application meets the requirements for patentability, and respectfully requests that the Board remand the present application to the Examiner instructing the Examiner to allow the present application.

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CONCLUSION

In view of the foregoing, it is submitted that none of the references of record, when

considered either alone or in any proper combination thereof, anticipate or render obvious the

Appellant's invention as recited in Claims 1-9, 11 and 19-24. The applied references of

record have been discussed and distinguished, while significant claimed features of the

present invention have been pointed out.

Appellant respectfully submits that each and every pending claim of the present

invention meets the requirements for patentability under 35 U.S.C. §§ 112, 102 and 103, and

requests that all of the aforementioned rejections be reversed by the Board, and the

application be remanded to the Examiner for withdrawal of all the rejections and allowance

of all pending claims.

Accordingly, immediate allowance of the claims in the present application is

respectfully requested and believed to be appropriate.

By:

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Respectfully submitted

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APPENDIX

CLAIMS ON APPEAL

1. (Previously Presented) A semiconductor package comprising:

a plurality of leads, each of the leads defining:

a first surface;

a second surface disposed in opposed relation to the first surface; and

a third surface disposed in opposed relation to the second surface, the first surface being oriented between the second and third surfaces;

a first semiconductor die defining opposed first and second surfaces and including a plurality of bond pads disposed on the first surface thereof, portions of the first surface of the first semiconductor die being directly attached to the second surface of each of the leads such that each of the bond pads of the first semiconductor die is located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact the second surface of any one of the leads;

a second semiconductor die defining opposed first and second surfaces and including a plurality of bond pads disposed on the second surface thereof, the first surface of the second semiconductor die being attached to the second surface of the first semiconductor die;

a plurality of conductive connectors electrically connecting the bond pads of the first and second semiconductor dies to respective ones of the leads; and

an encapsulating portion applied to and at least partially encapsulating the leads, the first and second semiconductor dies, and the conductive connectors.

- 2. (Original) The semiconductor package of Claim 1 wherein the conductive connectors comprise conductive wires.
 - 3. (Previously Presented) The semiconductor package of Claim 1 wherein:
 the conductive connectors comprise first and second conductive wires;
 the bond pads of the first semiconductor die are electrically connected to
 respective ones of the first surfaces of the leads by the first conductive wires; and

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the bond pads of the second semiconductor die are electrically connected to respective ones of the second surfaces of the leads by the second conductive wires.

4. (Original) The semiconductor package of Claim 1 further comprising:

a die paddle defining opposed top and bottom surfaces, the leads being disposed about the die paddle;

the first surface of the first semiconductor die further being attached to the top surface of the die paddle.

5. (Original) The semiconductor package of Claim 4 wherein:

the first surface of the first semiconductor die is attached to the second surface of each of the leads and to the top surface of the die paddle by a first bonding means; and

the first surface of the second semiconductor die is attached to the second surface of the first semiconductor die by a second bonding means.

6. (Original) The semiconductor package of Claim 4 wherein:

the die paddle is formed to have a die paddle thickness;

each of the leads is formed to have a lead thickness between the second and third surfaces thereof; and

the die paddle thickness is substantially equal to the lead thickness.

- 7. (Original) The semiconductor package of Claim 4 wherein the encapsulating portion is applied to the die paddle such that the bottom surface of the die paddle is exposed within the encapsulating portion.
- 8. (Original) The semiconductor package of Claim 7 wherein the encapsulating portion is applied to the leads such that the third surface of each of the leads is exposed within the encapsulating portion.
- 9. (Original) The semiconductor package of Claim 1 wherein the encapsulating portion is applied to the leads such that the third surface of each of the leads is exposed within the encapsulating portion.
 - 10. (Cancelled)
 - 11. (Previously Presented) The semiconductor package of Claim 1 wherein: the first semiconductor die defines a peripheral edge; and

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the conductive connectors electrically connecting the bond pads of the first semiconductor die to the leads are oriented inwardly relative to the peripheral edge of the first semiconductor die.

12-18. (Cancelled)

- 19. (Previously Presented) A semiconductor package comprising:
 - a plurality of leads;
- a first semiconductor die including a plurality of bond pads disposed thereon, the first semiconductor die being directly attached to each of the leads such that each of the bond pads of the first semiconductor die is located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact any of the leads;
- a second semiconductor die including a plurality of bond pads disposed thereon, the second semiconductor die being attached to the first semiconductor die;

means for electrically connecting the bond pads of the first and second semiconductor dies to respective ones of the leads; and

an encapsulating portion applied to and at least partially encapsulating the leads, the first and second semiconductor dies, and the electrical connection means.

- 20. (Previously Presented) The semiconductor package of Claim 19 wherein the electrical connection means comprises conductive wires.
 - 21. (Previously Presented) The semiconductor package of Claim 20 wherein:

each of the leads defines opposed first and second surfaces and a third surface which is opposed to the second surface, the first surface being oriented between the second and third surfaces;

the bond pads of the first semiconductor die are electrically connected to respective ones of the first surfaces of the leads by first conductive wires; and

the bond pads of the second semiconductor die are electrically connected to respective ones of the second surfaces of the leads by second conductive wires.

22. (Previously Presented) The semiconductor package of Claim 21 wherein the encapsulating portion is applied to the leads such that the third surface of each of the leads is exposed within the encapsulating portion.

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23. (Previously Presented) The semiconductor package of Claim 19 further comprising:

a die paddle, the leads being disposed about the die paddle; the first semiconductor die being attached to the die paddle.

24. (Previously Presented) The semiconductor package of Claim 23 wherein:

the die paddle defines opposed top and bottom surfaces, with the first semiconductor die being attached to the top surface of the die paddle; and

the encapsulating portion is applied to the die paddle such that the bottom surface of the die paddle is exposed within the encapsulating portion.

25. (Cancelled)

PTO/SB/21 (08-03) Approved for use through 07/31/2006. OMB 0651-0031

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Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number. Application Number 10/043,946 **TRANSMITTAL** Filing Date 01/11/2002 **FORM** First Named Inventor Jong Sik Paek Art Unit 2822 (to be used for all correspondence after initial filing) **Examiner Name** Monica Lewis Attorney Docket Number AMKOR-017RCE

Total Number of Pages in This Submission	11111	KOR-017RCL
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AP/2822 AN

IN THE UNITED STATES FAXENT AND TRADEMARK OFFICE

Confirmation No. 6383 Applicants: Jong Sik Paek Serial No.: 10/043,946 Art Unit: 2822 Examiner: Filed: 01/11/2002 Lewis, Monica For: Semiconductor Package with Stacked Dies

REQUEST FOR REINSTATEMENT OF APPEAL UNDER § 1.193(b)(2)(ii)

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir/Madam:

Applicant respectfully requests that the Appeal Brief filed under 37 C.F.R. §1.192 on October 12, 2004, be reinstated under 37 C.F.R. §1.193(b)(2)(ii). Applicant submits that the Examiner's new Final Office Action mailed January 4, 2005 is inappropriate because it does not provide a new ground of rejection as defined under M.P.E.P. § 1208.01. Instead, the Examiner has only made minor changes to the arguments (initially provided in the Final Office Action of May 19, 2004), and as a result, the *de minimus* changes do not constitute a new ground of rejection. Therefore, the most appropriate response from Examiner should be an Examiner's Answer under 37 C.F.R. §1.193(a)(1). The rationale behind the Applicant's Request for Reinstatement is herein discussed in more detail below.

Prosecution History

In response the Final Office Action of May 19, 2004, Applicant filed a Notice of Appeal on September 17, 2004 and an Appeal Brief on October 12, 2004. In reply to the Applicant's Appeal Brief, the Examiner has reopened prosecution. In particular, a new Final Office Action [hereinafter "the new Final Office Action"] was mailed to the Applicant on January 4, 2005.

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The New Final Office Action

In the new Final Office Action, the Examiner withdraws the finality of the previous Final Office Action (as best understood, the Final Office Action mailed on May 19, 2004 [hereinafter "previous Final Office Action"]). Moreover, the Examiner submits that Applicant's arguments with respect to Claims 1-9, 11 and 19-24 have been considered but are moot in view of "the new ground(s) of rejection."

Applicant submits that although it appears there have been some minor changes to the substance of the Examiner's arguments made in the previous Final Office Action mailed on May 19, 2004, the aforementioned changes are *de minimus* and do not constitute a "new ground of rejection". M.P.E.P. §1208.01, entitled *Prohibition Against Entry of New Ground of Rejection and Examiner's Answer*, states the following:

37 C.F.R. §1.193(a)(2) prohibits the entry of a new ground of rejection in an Examiner's Answer. At the time of preparing the Answer to an Appeal Brief, however, the Examiner may decide that he or she should apply a new ground of rejection against some or all of the Appeal claims. In such an instance where a new ground of rejection is necessary, the Examiner should reopen prosecution.

There is no new ground of rejection when the basic thrust of the rejection remains the same such that and appellant has been given a fair opportunity to react to the rejection. See *In re Kronig*, 539 F.2d 1300, 1302-03,190 USPQ 425, 426-7 (CCTA 1976). Where the statutory basis for the rejection remains the same and the evidence relied upon for the rejection remains the same, a change in the discussion of, or rational in support of, the rejection does not necessarily constitute a new ground of rejection. *Id.* at 1303, 190 USPQ at 427 (reliance upon fewer references and affirming a rejection under 35 U.S.C. §103 does not constitute a new ground of rejection)."

A review through the case history of the present application clearly supports Applicant's position that the changes in the Examiner's rejection of the pending claims from the previous Final Office Action of May 19, 2004, as compared to the new Final Office Action of January 4, 2005, does not constitute "new ground(s) of rejection". In particular, in the previous Final Office Action of May 19, 2004, the Examiner rejected Claims 1-6, 9, 11 and 19-25 under 35 U.S.C. §103(a) as obvious over U.S. Patent No. 6,198,171 to Huang et al. in view of U.S. Patent No. 6,410,979 to Abe. In the new Final Office Action of January 4, 2005, the exact rejections are made again, except for a few minor variations in the characterizations of the prior art.

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For example, with respect to the rejection of Claim 1 under 35 U.S.C. §103(a) as being obvious over Huang in view of Abe, the only changes made to the Examiner's new rejection, is that the Examiner has recharacterized the first surface as Haung element 330, instead of Huang element 328a; and the Examiner has recharacterized the second surface as Haung element 328a instead of Huang element 330. Additionally, the Examiner has reworded item "f)" of the aforementioned rejection from:

"f) the first semiconductor die of the leads being oriented relative to the other such that each of the bond pads of the first semiconductor die is located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact the second surface of any one of the leads (for Example: See Figure 7);"

to:

--- f) the first semiconductor die and the bond pads of the first semiconductor die are located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact the second surface of one of the leads (for Example: See Figure 7);" ---

There also appears to be a minor change in the rejection of Claim 11, where the Examiner has reworded item "c)" of the rejection from:

"c) the first semiconductor die and the leads being oriented relative to other such that each of the bond pads of the first semiconductor die is located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact the second surface of any one of the leads (For Example: See Figure 7);"

<u>to</u>:

--- c) the first semiconductor die and the bond pads of the first semiconductor die are located between a respective pair of the leads so that the bond pads of the first semiconductor die do not contact the second surface of any one of the leads (For Example: See Figure 7); ---

Additionally, Claims 7 and 8 are rejected under 35 U.S.C. §103(a) as obvious over Huang in view of Abe and Korean Publication No. 2002049944 to Song; however, this rejection appears to be the same in each Final Office Action.

CONCLUSION

The aforementioned changes in the Examiner's argument simply do not constitute new grounds of rejection. Rather, the thrust of the Examiner's rejection remains the same

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from the previous Final Office Action of May 19, 2004 to the new Final Office Action issued January 4, 2005.

As stated, in MPEP §1208.01, "[w]here the statutory basis for the rejection remains the same, and the evidence relied upon in the support of the rejection remains the same, a change in the discussion of, or rational in support of, the rejection does not necessarily constitute a new ground of rejection." Therefore, the *de minimus* changes that were made from the previous Final Office Action of May 19, 2004 to the new Final Office Action of January 4, 2005 do not constitute a new ground of rejection.

As a consequence, the Examiner's procedure of reopening prosecution after appeal is inappropriate in this circumstance. Instead, the aforementioned changes to the Examiner's arguments are procedurally required to be made in an Examiner's Answer under 37 C.F.R. §1.193.

Accordingly, Applicant respectfully requests under §1.193(b)(2)(ii), that the Appeal Brief filed on October 12, 2004 be officially reinstated. In accordance with §1.193(b)(2)(ii), a Supplemental Appeal Brief is being submitted in triplicate pursuant to 37 C.F.R. §1.192(a), with the understanding that the proper fees, which have already been paid with respect to the Notice of Appeal filed on September 17, 2004 and an Appeal Brief on October 12, 2004, are not required (see M.P.E.P. §1208.02).

If there are any questions pertaining to the aforementioned Request for Reinstatement, the Examiner is respectfully invited to discuss such matters with the Applicant's representative listed below.

Date: NROS
By:

Customer No.: 007663

Respectfully submitted,

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